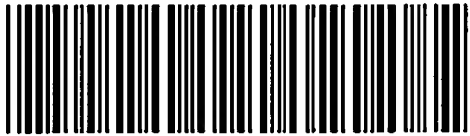


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/695,253	YIREN HONG	
	Examiner	Art Unit	
	Yahveh Comas	2834	

SEARCHED			
Class	Subclass	Date	Examiner
310	51, 67r	3/4/2005	YC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR